

## Supporting Information

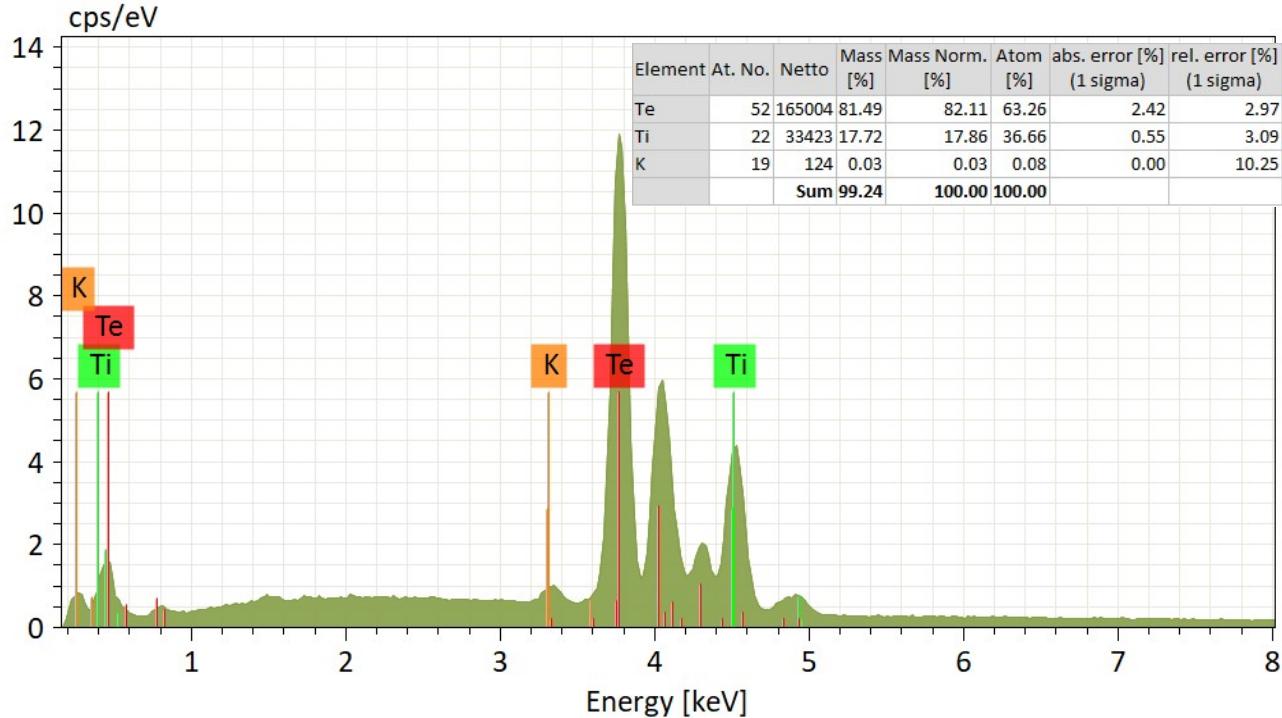
# Single crystal growth of layered metallic materials $\text{TiTe}_2$ based on a polytelluride flux method

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**Fig. S1** The EDS spectrum of TiTe<sub>2</sub> from polytelluride flux in this work.

**Table. S1** Work functions of the VB group TMDs reported in previous literatures.

Sample	Work function (eV)	methods	reference
VS <sub>2</sub>	4.37	KPFM <sup>*1</sup>	[1]
1T-VSe <sub>2</sub> (bulk)	5.76	TCS <sup>*2</sup>	[2]
1T-VSe <sub>2</sub> (monolayer)	5.52	TCS	[3]
NbSe <sub>2</sub>	5.9	UPS <sup>*3</sup>	[4]
NbS <sub>2</sub>	4.75~4.9	UPS	[5]
1T-TaS <sub>2</sub>	5.7	TCS	[6]

KPFM<sup>\*1</sup>: Kelvin probe force microscopy

TCS<sup>\*2</sup>: Target-current spectroscopy

UPS<sup>\*3</sup>: Ultraviolet photoelectron spectroscopy

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